

**Notice of References Cited**Application/Control No.  
09/633,145Applicant(s)/Patent Under  
Reexamination  
KODIRA ET AL.Examiner  
Sandra WegertArt Unit  
1647

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**U.S. PATENT DOCUMENTS**

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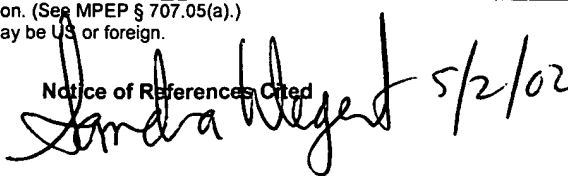
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Lee, et al, 2000, Accession No. AF112460.
	V	Lee, et al, 2000, Accession No. AF112461.
	W	Federal Register, 2001, 66: 1094-1099.
	X	Ji, et al, 1998, p. 17299-17302, 3rd paragraph

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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